Search Notes



Application/Control No.		

Reexamination
RAJU ET AL.

110617616

NAJU ET AL.

Applicant(s)/Patent Under

Examiner

Art Unit

SUN JAE Y LOEWE

1626

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
restriction requirement	3-12-2008	sl
STN: registry & caplus	5-5-2008	sl
PALM all inventors	5-5-2008	sl
STN: registry & caplus updated	12-19-2008	sl
PALM all inventors updated	12-19-2008	sl
STN registry & caplus updated	11-9-2009	sl
PALM all inventors updated	11-9-2009	sl
patentability conference: G. Shameem, K. Saeed	11-9-2009	sl

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
514	210.17	11-9-2009	sl
548	950	11-9-2009	sl

U.S. Patent and Trademark Office Part of Paper No.: 20091109